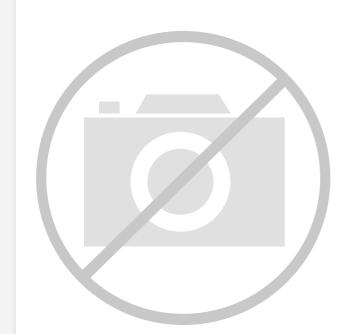
Lattice Semiconductor Corporation - <u>LC4064ZE-4MN64C Datasheet</u>



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Understanding <u>Embedded - CPLDs (Complex</u> <u>Programmable Logic Devices)</u>

Embedded - CPLDs, or Complex Programmable Logic Devices, are highly versatile digital logic devices used in electronic systems. These programmable components are designed to perform complex logical operations and can be customized for specific applications. Unlike fixedfunction ICs, CPLDs offer the flexibility to reprogram their configuration, making them an ideal choice for various embedded systems. They consist of a set of logic gates and programmable interconnects, allowing designers to implement complex logic circuits without needing custom hardware.

Applications of Embedded - CPLDs

Details

Product Status	Active
Programmable Type	In System Programmable
Delay Time tpd(1) Max	4.7 ns
Voltage Supply - Internal	1.7V ~ 1.9V
Number of Logic Elements/Blocks	4
Number of Macrocells	64
Number of Gates	-
Number of I/O	48
Operating Temperature	0°C ~ 90°C (TJ)
Mounting Type	Surface Mount
Package / Case	64-TFBGA, CSPBGA
Supplier Device Package	64-CSBGA (5x5)
Purchase URL	https://www.e-xfl.com/product-detail/lattice-semiconductor/lc4064ze-4mn64c

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



Introduction

The high performance ispMACH 4000ZE family from Lattice offers an ultra low power CPLD solution. The new family is based on Lattice's industry-leading ispMACH 4000 architecture. Retaining the best of the previous generation, the ispMACH 4000ZE architecture focuses on significant innovations to combine high performance with low power in a flexible CPLD family. For example, the family's new Power Guard feature minimizes dynamic power consumption by preventing internal logic toggling due to unnecessary I/O pin activity.

The ispMACH 4000ZE combines high speed and low power with the flexibility needed for ease of design. With its robust Global Routing Pool and Output Routing Pool, this family delivers excellent First-Time-Fit, timing predictability, routing, pin-out retention and density migration.

The ispMACH 4000ZE family offers densities ranging from 32 to 256 macrocells. There are multiple density-I/O combinations in Thin Quad Flat Pack (TQFP), Chip Scale BGA (csBGA), and Ultra Chip Scale BGA (ucBGA) packages ranging from 32 to 144 pins/balls. Table 1 shows the macrocell, package and I/O options, along with other key parameters.

A user programmable internal oscillator and a timer are included in the device for tasks like LED control, keyboard scanner and similar housekeeping type state machines. This feature can be optionally disabled to save power.

The ispMACH 4000ZE family has enhanced system integration capabilities. It supports a 1.8V supply voltage and 3.3V, 2.5V, 1.8V and 1.5V interface voltages. Additionally, inputs can be safely driven up to 5.5V when an I/O bank is configured for 3.3V operation, making this family 5V tolerant. The ispMACH 4000ZE also offers enhanced I/O features such as slew rate control, PCI compatibility, bus-keeper latches, pull-up resistors, pull-down resistors, open drain outputs and hot socketing. Pull-up, pull-down and bus-keeper features are controllable on a "per-pin" basis. The ispMACH 4000ZE family members are 1.8V in-system programmable through the IEEE Standard 1532 interface. IEEE Standard 1149.1 boundary scan testing capability also allows product testing on automated test equipment. The 1532 interface signals TCK, TMS, TDI and TDO are referenced to V_{CC} (logic core).

Overview

The ispMACH 4000ZE devices consist of multiple 36-input, 16-macrocell Generic Logic Blocks (GLBs) interconnected by a Global Routing Pool (GRP). Output Routing Pools (ORPs) connect the GLBs to the I/O Blocks (IOBs), which contain multiple I/O cells. This architecture is shown in Figure 1.

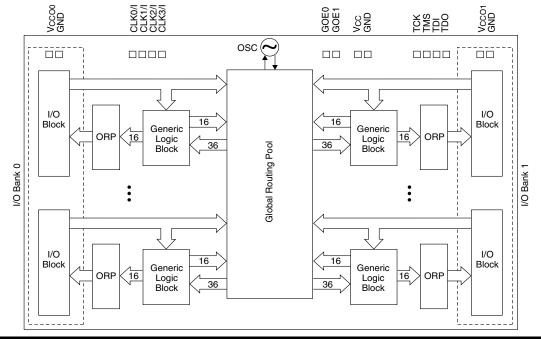
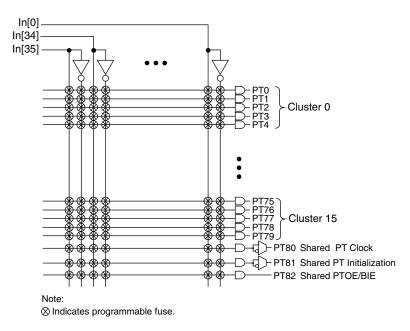


Figure 1. Functional Block Diagram



Figure 3. AND Array



Enhanced Logic Allocator

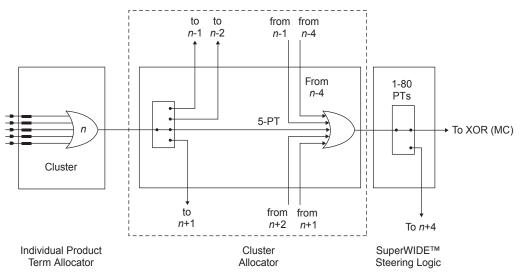
Within the logic allocator, product terms are allocated to macrocells in product term clusters. Each product term cluster is associated with a macrocell. The cluster size for the ispMACH 4000ZE family is 4+1 (total 5) product terms. The software automatically considers the availability and distribution of product term clusters as it fits the functions within a GLB. The logic allocator is designed to provide two speed paths: 20-PT Speed Locking path and an up to 80-PT path. The availability of these two paths lets designers trade timing variability for increased performance.

The enhanced Logic Allocator of the ispMACH 4000ZE family consists of the following blocks:

- Product Term Allocator
- Cluster Allocator
- Wide Steering Logic

Figure 4 shows a macrocell slice of the Logic Allocator. There are 16 such slices in the GLB.

Figure 4. Macrocell Slice





Product Term Allocator

The product term allocator assigns product terms from a cluster to either logic or control applications as required by the design being implemented. Product terms that are used as logic are steered into a 5-input OR gate associated with the cluster. Product terms that used for control are steered either to the macrocell or I/O cell associated with the cluster. Table 2 shows the available functions for each of the five product terms in the cluster.

Product Term	Logic	Control
PT <i>n</i>	Logic PT	Single PT for XOR/OR
PT <i>n</i> +1	Logic PT	Individual Clock (PT Clock)
PT <i>n</i> +2	Logic PT	Individual Initialization or Individual Clock Enable (PT Initialization/CE)
PT <i>n</i> +3	Logic PT	Individual Initialization (PT Initialization)
PT <i>n</i> +4	Logic PT	Individual OE (PTOE)

Cluster Allocator

The cluster allocator allows clusters to be steered to neighboring macrocells, thus allowing the creation of functions with more product terms. Table 3 shows which clusters can be steered to which macrocells. Used in this manner, the cluster allocator can be used to form functions of up to 20 product terms. Additionally, the cluster allocator accepts inputs from the wide steering logic. Using these inputs, functions up to 80 product terms can be created.

Macrocell	Available Clusters							
MO	—	C0	C1	C2				
M1	C0	C1	C2	C3				
M2	C1	C2	C3	C4				
M3	C2	C3	C4	C5				
M4	C3	C4	C5	C6				
M5	C4	C5	C6	C7				
M6	C5	C6	C7	C8				
M7	C6	C7	C8	C9				
M8	C7	C8	C9	C10				
M9	C8	C9	C10	C11				
M10	C9	C10	C11	C12				
M11	C10	C11	C12	C13				
M12	C11	C12	C13	C14				
M13	C12	C13	C14	C15				
M14	C13	C14	C15	—				
M15	C14	C15	_	_				

Table 3. Available Clusters for Each Macrocell

Wide Steering Logic

The wide steering logic allows the output of the cluster allocator n to be connected to the input of the cluster allocator n+4. Thus, cluster chains can be formed with up to 80 product terms, supporting wide product term functions and allowing performance to be increased through a single GLB implementation. Table 4 shows the product term chains.



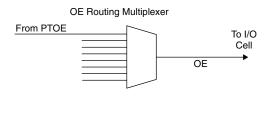
Output Routing Pool (ORP)

The Output Routing Pool allows macrocell outputs to be connected to any of several I/O cells within an I/O block. This provides greater flexibility in determining the pinout and allows design changes to occur without affecting the pinout. The output routing pool also provides a parallel capability for routing macrocell-level OE product terms. This allows the OE product term to follow the macrocell output as it is switched between I/O cells. The enhanced ORP of the ispMACH 4000ZE family consists of the following elements:

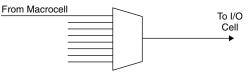
- Output Routing Multiplexers
- OE Routing Multiplexers

Figure 7 shows the structure of the ORP from the I/O cell perspective. This is referred to as an ORP slice. Each ORP has as many ORP slices as there are I/O cells in the corresponding I/O block.

Figure 7. ORP Slice



Output Routing Multiplexer



Output Routing Multiplexers

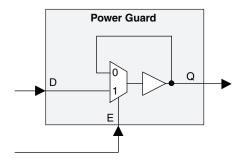
The details of connections between the macrocells and the I/O cells vary across devices and within a device dependent on the maximum number of I/Os available. Tables 5-7 provide the connection details.

Table 5. GLB/MC/ORP Combinations for ispMACH 4256ZE

GLB/MC	ORP Mux Input Macrocells
[GLB] [MC 0]	M0, M1, M2, M3, M4, M5, M6, M7
[GLB] [MC 1]	M2, M3, M4, M5, M6, M7, M8, M9
[GLB] [MC 2]	M4, M5, M6, M7, M8, M9, M10, M11
[GLB] [MC 3]	M6, M7, M8, M9, M10, M11, M12, M13
[GLB] [MC 4]	M8, M9, M10, M11, M12, M13, M14, M15
[GLB] [MC 5]	M10, M11, M12, M13, M14, M15, M0, M1
[GLB] [MC 6]	M12, M13, M14, M15, M0, M1, M2, M3
[GLB] [MC 7]	M14, M15, M0, M1, M2, M3, M4, M5



Figure 9. Power Guard

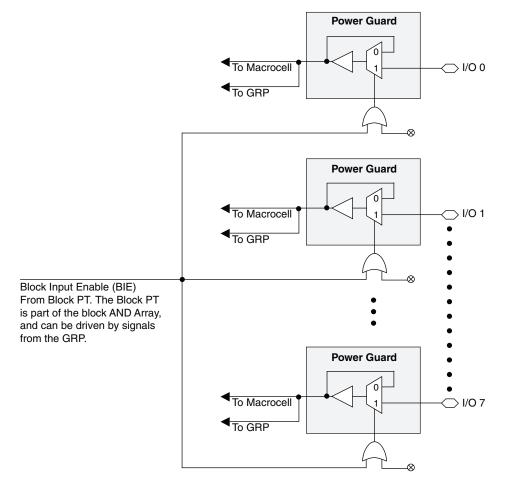


All the I/O pins in a block share a common Power Guard Enable signal. For a block of I/Os, this signal is called a Block Input Enable (BIE) signal. BIE can be internally generated using MC logic, or could come from external sources using one of the user I/O or input pins.

Any I/O pin in the block can be programmed to ignore the BIE signal. Thus, the feature can be enabled or disabled on a pin-by-pin basis.

Figure 10 shows Power Guard and BIE across multiple I/Os in a block that has eight I/Os.

Figure 10. Power Guard and BIE in a Block with 8 I/Os





The block-level OE PT of each GLB is also tied to Block Input Enable (BIE) of that block. Hence, for a 256-macrocell device (with 16 blocks), each block's BIE signal is driven by block-level OE PT from each block.



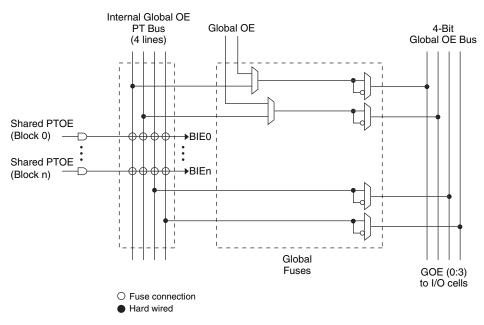
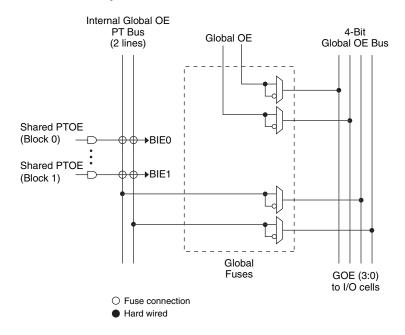


Figure 12. Global OE Generation for ispMACH 4032ZE



On-Chip Oscillator and Timer

An internal oscillator is provided for use in miscellaneous housekeeping functions such as watchdog heartbeats, digital de-glitch circuits and control state machines. The oscillator is disabled by default to save power. Figure 13 shows the block diagram of the oscillator and timer block.



Figure 13. On-Chip Oscillator and Timer



Table 11. On-Chip Oscillator and Timer Signal Names

Signal Name	Input or Out- put	Optional / Required	Description
OSCOUT	Output	Optional	Oscillator Output (Nominal Frequency: 5MHz)
TIMEROUT	Output	Optional	Oscillator Frequency Divided by an integer TIMER_DIV (Default 128)
TIMERRES	Input	Optional	Reset the Timer
DYNOSCDIS	Input	Optional	Disables the Oscillator, resets the Timer and saves the power.

OSCTIMER has two outputs, OSCOUT and TIMEROUT. The outputs feed into the Global Routing Pool (GRP). From GRP, these signals can drive any macrocell input, as well as any output pin (with macrocell bypass). The output OSCOUT is the direct oscillator output with a typical frequency of 5MHz, whereas, the output TIMEROUT is the oscillator output divided by an attribute TIMER_DIV.

The attribute TIMER_DIV can be: 128 (7 bits), 1024 (10 bits) or 1,048,576 (20 bits). The divided output is provided for those user situations, where a very slow clock is desired. If even a slower toggling clock is desired, then the programmable macrocell resources can be used to further divide down the TIMEROUT output.

Figure 14 shows the simplified relationship among OSCOUT, TIMERRES and TIMEROUT. In the diagram, the signal " \overline{R} " is an internal reset signal that is used to synchronize TIMERRES to OSCOUT. This adds one extra clock cycle delay for the first timer transition after TIMERRES.

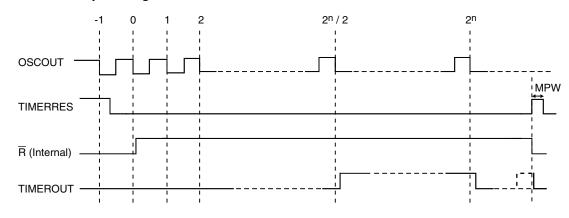


Figure 14. Relationship Among OSCOUT, TIMERRES and TIMEROUT

Note: n = Number of bits in the divider (7, 10 or 20) Metastability: If the signal TIMERRES is not synchronous to OSCOUT, it could make a difference of one or two clock cycles to the TIMEROUT going high the first time.



I/O Recommended Operating Conditions

	V _{CCC}	_D (V) ¹
Standard	Min.	Max.
LVTTL	3.0	3.6
LVCMOS 3.3	3.0	3.6
Extended LVCMOS 3.3	2.7	3.6
LVCMOS 2.5	2.3	2.7
LVCMOS 1.8	1.65	1.95
LVCMOS 1.5	1.4	1.6
PCI 3.3	3.0	3.6

1. Typical values for V_{CCO} are the average of the min. and max. values.

DC Electrical Characteristics

Over Recommended Operating Conditions

Symbol	Parameter	Condition	Min.	Тур.	Max.	Units
$I_{\rm IL}, I_{\rm IH}^{1,2}$	Input Leakage Current	$0 \le V_{IN} < V_{CCO}$	—	0.5	1	μΑ
I _{IH} ¹	Input High Leakage Current	$V_{CCO} < V_{IN} \le 5.5V$	—		10	μΑ
I _{PU}	I/O Weak Pull-up Resistor Current	$0 \leq V_{IN} \leq 0.7 V_{CCO}$	-20		-150	μΑ
I _{PD}	I/O Weak Pull-down Resistor Current	V_{IL} (MAX) $\leq V_{IN} \leq V_{IH}$ (MAX)	30		150	μA
I _{BHLS}	Bus Hold Low Sustaining Current	$V_{IN} = V_{IL} (MAX)$	30		—	μΑ
I _{BHHS}	Bus Hold High Sustaining Current	$V_{IN} = 0.7 V_{CCO}$	-20		—	μΑ
I _{BHLO}	Bus Hold Low Overdrive Current	$0V \le V_{IN} \le V_{BHT}$	—		150	μΑ
I _{BHHO}	Bus Hold High Overdrive Current	$V_{BHT} \le V_{IN} \le V_{CCO}$	—		-150	μΑ
V _{BHT}	Bus Hold Trip Points	—	V _{CCO} * 0.35		V _{CCO} * 0.65	V
C ₁	I/O Capacitance ³	V _{CCO} = 3.3V, 2.5V, 1.8V, 1.5V	—	8	—	pf
01	1/O Capacitance	$V_{CC} = 1.8V$, $V_{IO} = 0$ to V_{IH} (MAX)	—	0	—	рі
C ₂	Clock Capacitance ³	V _{CCO} = 3.3V, 2.5V, 1.8V, 1.5V	—	6	—	nf
02	Clock Capacitance	$V_{CC} = 1.8V$, $V_{IO} = 0$ to V_{IH} (MAX)	—	0	—	pf
C ₃	Global Input Capacitance ³	V _{CCO} = 3.3V, 2.5V, 1.8V, 1.5V	—	6	—	pf
\cup_3		V_{CC} = 1.8V, V_{IO} = 0 to V_{IH} (MAX)	—	0	—	Ы

1. Input or I/O leakage current is measured with the pin configured as an input or as an I/O with the output driver tristated. It is not measured with the output driver active. Bus maintenance circuits are disabled.

 I_{IH} excursions of up to 1.5µA maximum per pin above the spec limit may be observed for certain voltage conditions on no more than 10% of the device's I/O pins.

3. Measured $T_A = 25^{\circ}C$, f = 1.0MHz.



ispMACH 4000ZE External Switching Characteristics

		LC40)32ZE	LC40	64ZE		All De	evices		
			4	-	4	-	5	-	7	
Parameter	Description ^{1, 2}	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{PD}	20-PT combinatorial propagation delay	—	4.4	—	4.7	—	5.8	—	7.5	ns
t _S	GLB register setup time before clock	2.2	—	2.5	—	2.9	—	4.5	—	ns
t _{ST}	GLB register setup time before clock with T-type register	2.4	_	2.7	—	3.1	—	4.7	—	ns
t _{SIR}	GLB register setup time before clock, input register path	1.0	_	1.1	—	1.3	—	1.4	—	ns
t _{SIRZ}	GLB register setup time before clock with zero hold	2.0	_	2.1	—	2.9	—	4.0	—	ns
t _H	GLB register hold time after clock	0.0	_	0.0	—	0.0	—	0.0	—	ns
t _{HT}	GLB register hold time after clock with T-type register	0.0	_	0.0	—	0.0	—	0.0	—	ns
t _{HIR}	GLB register hold time after clock, input register path	1.0	_	1.0	—	1.3	—	1.3	—	ns
t _{HIRZ}	GLB register hold time after clock, input register path with zero hold	0.0	_	0.0	—	0.0	—	0.0	—	ns
t _{co}	GLB register clock-to-output delay	_	3.0	—	3.2	—	3.8	_	4.5	ns
t _R	External reset pin to output delay	—	5.0	—	6.0	—	7.5	—	9.0	ns
t _{RW}	External reset pulse duration	1.5	_	1.7	—	2.0	—	4.0	—	ns
t _{PTOE/DIS}	Input to output local product term output enable/disable	_	7.0	—	8.0	_	8.2	_	9.0	ns
t _{GPTOE/DIS}	Input to output global product term output enable/disable	_	6.5	_	7.0	_	10.0	_	10.5	ns
t _{GOE/DIS}	Global OE input to output enable/disable	_	4.5	_	4.5	—	5.5		7.0	ns
t _{CW}	Global clock width, high or low	1.0	_	1.5	—	1.8	—	2.8	—	ns
t _{GW}	Global gate width low (for low transparent) or high (for high transparent)	1.0	_	1.5	_	1.8	_	2.8	_	ns
t _{WIR}	Input register clock width, high or low	1.0	—	1.5	—	1.8	—	2.8	—	ns
f _{MAX} (Int.) ³	Clock frequency with internal feedback		260	—	241		200		172	MHz
f _{MAX} (Ext.)	clock frequency with external feedback, $[1 / (t_S + t_{CO})]$	—	192	-	175	_	149	_	111	MHz

Over Recommended Operating Conditions

1. Timing numbers are based on default LVCMOS 1.8 I/O buffers. Use timing adjusters provided to calculate other standards.

Measured using standard switching GRP loading of 1 and 1 output switching.
Standard 16-bit counter using GRP feedback.

Timing v.0.8



Timing Model

The task of determining the timing through the ispMACH 4000ZE family, like any CPLD, is relatively simple. The timing model provided in Figure 16 shows the specific delay paths. Once the implementation of a given function is determined either conceptually or from the software report file, the delay path of the function can easily be determined from the timing model. The Lattice design tools report the timing delays based on the same timing model for a particular design. Note that the internal timing parameters are given for reference only, and are not tested. The external timing parameters are tested and guaranteed for every device. For more information on the timing model and usage, refer to TN1168, jspMACH 4000ZE Timing Model Design and Usage Guidelines.

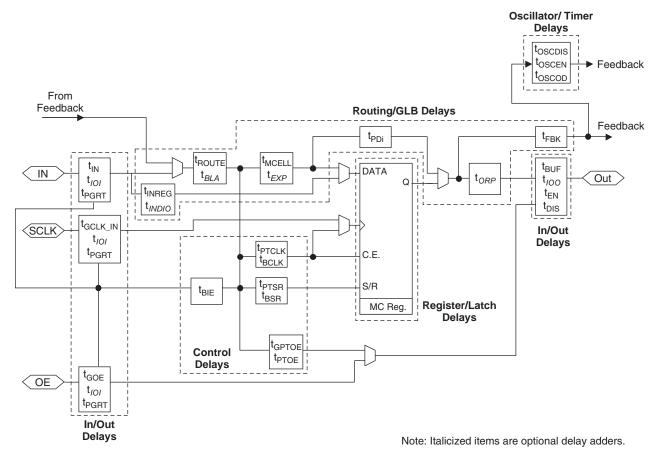


Figure 16. ispMACH 4000ZE Timing Model



ispMACH 4000ZE Internal Timing Parameters

		LC40)32ZE	LC40	64ZE	
			-4	-		
Parameter	Description	Min.	Max.	Min.	Max.	Units
In/Out Delays	•					
t _{IN}	Input Buffer Delay	_	0.85	_	0.90	ns
t _{GCLK_IN}	Global Clock Input Buffer Delay	_	1.60	—	1.60	ns
t _{GOE}	Global OE Pin Delay	_	2.25	—	2.25	ns
t _{BUF}	Delay through Output Buffer	_	0.75	—	0.90	ns
t _{EN}	Output Enable Time	_	2.25	—	2.25	ns
t _{DIS}	Output Disable Time		1.35	_	1.35	ns
t _{PGSU}	Input Power Guard Setup Time		3.30	_	3.55	ns
t _{PGH}	Input Power Guard Hold Time		0.00	_	0.00	ns
t _{PGPW}	Input Power Guard BIE Minimum Pulse Width	_	5.00	—	5.00	ns
t _{PGRT}	Input Power Guard Recovery Time Following BIE Dissertation	_	5.00	_	5.00	ns
Routing Delays					1	1
t _{ROUTE}	Delay through GRP	—	1.60	—	1.70	ns
t _{PDi}	Macrocell Propagation Delay	_	0.25	—	0.25	ns
t _{MCELL}	Macrocell Delay	_	0.65	—	0.65	ns
t _{INREG}	Input Buffer to Macrocell Register Delay		0.90	_	1.00	ns
t _{FBK}	Internal Feedback Delay	_	0.55	—	0.55	ns
t _{ORP}	Output Routing Pool Delay	_	0.30	—	0.30	ns
Register/Latcl	h Delays					l
t _S	D-Register Setup Time (Global Clock)	0.70	_	0.85	_	ns
t _{S_PT}	D-Register Setup Time (Product Term Clock)	1.25		1.85	_	ns
t _H	D-Register Hold Time	1.50		1.65		ns
t _{ST}	T-Register Setup Time (Global Clock)	0.90		1.05		ns
t _{ST_PT}	T-register Setup Time (Product Term Clock)	1.45		1.65	_	ns
t _{HT}	T-Resister Hold Time	1.50		1.65		ns
t _{SIR}	D-Input Register Setup Time (Global Clock)	0.85		0.80		ns
t _{SIR_PT}	D-Input Register Setup Time (Product Term Clock)	1.45		1.45		ns
t _{HIR}	D-Input Register Hold Time (Global Clock)	1.15		1.30		ns
t _{HIR_PT}	D-Input Register Hold Time (Product Term Clock)	0.90		1.10		ns
t _{COi}	Register Clock to Output/Feedback MUX Time		0.35		0.40	ns
t _{CES}	Clock Enable Setup Time	1.00		2.00		ns
t _{CEH}	Clock Enable Hold Time	0.00		0.00		ns
t _{SL}	Latch Setup Time (Global Clock)	0.70		0.95		ns
t _{SL_PT}	Latch Setup Time (Product Term Clock)	1.45		1.85		ns
t _{HL}	Latch Hold Time	1.40	<u> </u>	1.80		ns
t _{GOi}	Latch Gate to Output/Feedback MUX Time		0.40		0.35	ns
t _{PDLi}	Propagation Delay through Transparent Latch to Output/ Feedback MUX	_	0.30	_	0.25	ns
t _{SRi}	Asynchronous Reset or Set to Output/Feedback MUX Delay		0.30	—	0.30	ns





ispMACH 4000ZE Internal Timing Parameters (Cont.)

Over Recommended Operating Conditions

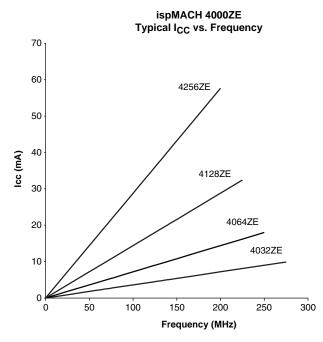
			All Devices				
			-	5	-	7	
Parameter	Description		Min.	Max.	Min.	Max.	Units
LVCMOS15_out	Output Configured as 1.5V Buffer	t _{EN} , t _{DIS} , t _{BUF}	—	0.20	—	0.20	ns
LVCMOS18_out	Output Configured as 1.8V Buffer	t _{EN} , t _{DIS} , t _{BUF}	—	0.00	_	0.00	ns
LVCMOS25_out	Output Configured as 2.5V Buffer	t _{EN} , t _{DIS} , t _{BUF}	—	0.10	—	0.10	ns
LVCMOS33_out	Output Configured as 3.3V Buffer	t _{EN} , t _{DIS} , t _{BUF}	—	0.20	_	0.20	ns
PCI_out	Output Configured as PCI Compati- ble Buffer	t _{EN} , t _{DIS} , t _{BUF}	_	0.20	—	0.20	ns
Slow Slew	Output Configured for Slow Slew Rate	t _{EN} , t _{BUF}	_	1.00	_	1.00	ns

Note: Internal Timing Parameters are not tested and are for reference only. Refer to the timing model in this data sheet for further details. Timing v.0.8





Power Consumption



Power Estimation Coefficients¹

Device	Α	В
ispMACH 4032ZE	0.010	0.009
ispMACH 4064ZE	0.011	0.009
ispMACH 4128ZE	0.012	0.009
ispMACH 4256ZE	0.013	0.009

1. For further information about the use of these coefficients, refer to TN1187, <u>Power Esti-</u> mation in ispMACH 4000ZE Devices.



Signal Descriptions

Signal Names	Description				
TMS	Input – This pin is the IEEE 1149.1 Test Mode Select input, which is used to control the state machine.				
ТСК	Input – This pin is the IEEE 1149.1 Test Clock input pin, used to clock through the state machine.				
TDI	Input – This pin is the IEEE 1149.1 Test D	ata In pin, used to load data.			
TDO	Output – This pin is the IEEE 1149.1 Test	Data Out pin used to shift data out.			
GOE0/IO, GOE1/IO	These pins are configured to be either Global Output Enable Input or as general I/O pins.				
GND	Ground				
NC	Not Connected				
V _{CC}	The power supply pins for logic core and JTAG port.				
CLK0/I, CLK1/I, CLK2/I, CLK3/I	These pins are configured to be either CLK input or as an input.				
V _{CCO0} , V _{CCO1}	The power supply pins for each I/O bank.	The power supply pins for each I/O bank.			
	Input/Output ¹ – These are the general purpose I/O used by the logic array. y is (reference (alpha) and z is macrocell reference (numeric). z: 0-15.				
	ispMACH 4032ZE	y: A-B			
yzz	ispMACH 4064ZE	y: A-D			
	ispMACH 4128ZE	y: A-H			
	ispMACH 4256ZE	y: A-P			

1. In some packages, certain I/Os are only available for use as inputs. See the Logic Signal Connections tables for details.

ORP Reference Table

	4032ZE		4064ZE		412	8ZE		4256ZE	
Number of I/Os	32	32	48	64	64	96	64	96	108
Number of GLBs	2	4	4	4	8	8	16	16	16
Number of I/Os per GLB	16	8	Mixture of 9, 10, 14, 15	16	8	12	4	6	Mixture of 6, 7, 8
Reference ORP Table (I/Os per GLB)	16	8	9, 10, 14, 15	16	8	12	4	6	6, 7, 8



ispMACH 4128ZE Logic Signal Connections: 132 ucBGA (Cont.)

Ball Number	Bank Number	GLB/MC/Pad
M5	0	D5
J6	0	D4
K6	0	D2
L6	0	D1
M6	0	D0
K7	0	CLK1/I
L7	1	GND (Bank 1)
J7	1	CLK2/I
M7	-	VCC
K8	1	E0
L8	1	E1
M8	1	E2
J8	1	E4
L9	1	E5
M9	1	E6
K9	1	VCCO (Bank 1)
J9	1	GND (Bank 1)
L10	1	E8
K10	1	E9
M10	1	E10
L11	1	E12
K12	1	E13
M11	1	E14
GND*	-	GND
M12	-	TMS
L12	1	VCCO (Bank 1)
K11	1	F0
J10	1	F1
H9	1	F2
J12	1	F4
J11	1	F5
H10	1	F6
H12	1	GND (Bank 1)
G9	1	F8
H11	1	F9
F9	1	F10
G12	1	F12
G11	1	F13
G10	1	F14
F12	1	VCCO (Bank 1)
F10	1	G14
F11	1	G13
E11	1	G12
E10	1	G10



ispMACH 4128ZE Logic Signal Connections: 132 ucBGA (Cont.)

Ball Number	Bank Number	GLB/MC/Pad
D10	1	G9
E12	1	G8
E9	1	GND (Bank 1)
D12	1	G6
D11	1	G5
C12	1	G4
C10	1	G2
C11	1	G1
B11	1	G0
D9	1	VCCO (Bank 1)
B12	-	TDO
A12	-	VCC
GND*	-	GND
A10	1	H14
A11	1	H13
B10	1	H12
C9	1	H10
D8	1	H9
C8	1	Н8
A9	1	GND (Bank 1)
C7	1	VCCO (Bank 1)
B9	1	H6
B8	1	H5
D7	1	H4
A8	1	H2
A7	1	H1
B6	1	H0/GOE1
C6	1	CLK3/I
B7	0	GND (Bank 0)
D6	0	CLK0/I
B5	-	VCC
A6	0	A0/GOE0
C5	0	A1
B4	0	A2
A5	0	A4
C4	0	A5
D5	0	A6
A4	0	VCCO (Bank 0)
B3	0	GND (Bank 0)
D4	0	A8
A3	0	A9
C3	0	A10
B2	0	A12
C2	0	A13



ispMACH 4064ZE, 4128ZE and 4256ZE Logic Signal Connections: 144 csBGA

Ball	Bank	LC4064ZE	LC4128ZE	LC4256ZE
Number	Number	GLB/MC/Pad	GLB/MC/Pad	GLB/MC/Pad
F6	-	GND	GND	GND
A1	-	TDI	TDI	TDI
E4	0	NC Ball	VCCO (Bank 0)	VCCO (Bank 0)
B2	0	NC Ball	B0	C12
B1	0	NC Ball	B1	C10
C3	0	A8	B2	C8
C2	0	A9	B4	C6
C1	0	A10	B5	C4
D1	0	A11	B6	C2
G5	0	GND (Bank 0)	GND (Bank 0)	GND (Bank 0)
D2	0	NC Ball	NC Ball	D14
D3	0	NC Ball	NC Ball	D12
E1	0	NC Ball	B8	D10
E2	0	A12	B9	D8
F2	0	A13	B10	D6
D4	0	A14	B12	D4
F1	0	A15	B13	D2
F3*	0		B14	D0
F4	0	VCCO (Bank 0)	VCCO (Bank 0)	VCCO (Bank 0)
G1	0	B15	C14	E0
E3	0	B14	C13	E2
G2	0	B13	C12	E4
G3	0	B12	C10	E6
H1	0	NC Ball	C9	E8
H3	0	NC Ball	C8	E10
H2	0	NC Ball	NC Ball	E12
H4	0	GND (Bank 0)	GND (Bank 0)	GND (Bank 0)
J1	0	B11	C6	F2
J3	0	B10	C5	F4
J2	0	B9	C4	F6
K1	0	B8	C2	F8
K2*	0	I	C1	F10
L1	0	NC Ball	CO	F12
G4	0	NC Ball	VCCO (Bank 0)	VCCO (Bank 0)
L2	-	ТСК	ТСК	ТСК
H5	-	VCC	VCC	VCC
G6	-	GND	GND	GND
M1	0	NC Ball	NC Ball	G14
K3	0	NC Ball	NC Ball	G12
M2	0	NC Ball	D14	G10
L3*	0		D13	G8



ispMACH 4128ZE and 4256ZE Logic Signal Connections: 144 TQFP (Cont.)

		LC4128ZE	LC4256ZE
Pin Number	Bank Number	GLB/MC/Pad	GLB/MC/Pad
86	1	F12	L8
87	1	F13	L6
88	1	F14	L4
89*	1	NC	I
90	1	GND (Bank 1)	NC
91	1	VCCO (Bank 1)	VCCO (Bank 1)
92*	1	NC	I
93	1	G14	M2
94	1	G13	M4
95	1	G12	M6
96	1	G10	M8
97	1	G9	M10
98	1	G8	M12
99	1	GND (Bank 1)	GND (Bank 1)
100	1	G6	N2
101	1	G5	N4
102	1	G4	N6
103	1	G2	N8
104	1	G1	N10
105	1	G0	N12
106	1	VCCO (Bank 1)	VCCO (Bank 1)
107	-	TDO	TDO
108	-	VCC	VCC
109	-	GND	GND
110*	1	NC	I
111	1	H14	O12
112	1	H13	O10
113	1	H12	O8
114	1	H10	O6
115	1	H9	04
116	1	H8	02
117*	1	NC	I
118	1	GND (Bank 1)	GND (Bank 1)
119	1	VCCO (Bank 1)	VCCO (Bank 1)
120	1	H6	P12
121	1	H5	P10
122	1	H4	P8
123	1	H2	P6
124	1	H1	P4
125	1	H0/GOE1	P2/GOE1
126	1	CLK3/I	CLK3/I
127	0	GND (Bank 0)	GND (Bank 0)
128	0	CLK0/I	CLK0/I



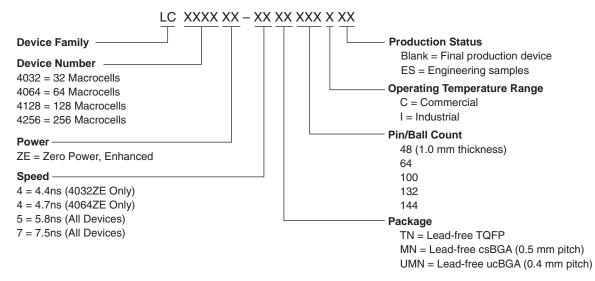
ispMACH 4128ZE and 4256ZE Logic Signal Connections: 144 TQFP (Cont.)

		LC4128ZE	LC4256ZE	
Pin Number	Bank Number	GLB/MC/Pad	GLB/MC/Pad	
129	-	VCC	VCC	
130	0	A0/GOE0	A2/GOE0	
131	0	A1	A4	
132	0	A2	A6	
133	0	A4	A8	
134	0	A5	A10	
135	0	A6	A12	
136	0	VCCO (Bank 0)	VCCO (Bank 0	
137	0	GND (Bank 0)	GND (Bank 0)	
138	0	A8	B2	
139	0	A9	B4	
140	0	A10	B6	
141	0	A12	B8	
142	0	A13	B10	
143	0	A14		
144*	0	NC	I	

* This pin is input only for the LC4256ZE.



Part Number Description



ispMACH 4000ZE Family Speed Grade Offering

	-4	-5		-7	
	Commercial	Commercial	Industrial	Commercial	Industrial
ispMACH 4032ZE	~	~	\checkmark	~	✓
ispMACH 4064ZE	~	~	~	~	\checkmark
ispMACH 4128ZE		~		~	\checkmark
ispMACH 4256ZE		\checkmark		✓	\checkmark

Ordering Information

Note: ispMACH 4000ZE devices are dual marked except for the slowest commercial speed grade. For example, the commercial speed grade LC4128ZE-5TN100C is also marked with the industrial grade -7I. The commercial grade is always one speed grade faster than the associated dual mark industrial grade. The slowest commercial speed grade devices are marked as commercial grade only. The markings appear as follows:

Figure 18. Mark Format for 100 TQFP and 144 TQFP Packages

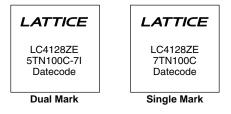


Figure 19. Mark Format for 48 TQFP, 64 csBGA and 144 csBGA Packages

